Issue Classification

Application/Control No.	Applicant(s)/Patent Under Reexamination
10624489	VIERICH ET AL.
Examiner	**Art Unit**
Lin, Shew-Fen	2166

ORIGINAL	
CLASS	SUBCLASS
707	102

CROSS REFERENCE(S)

CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
715	854				

INTERNATIONAL CLASSIFICATION

CLAIMED	NON-CLAIMED
G 06 F 7/00	
G 06 F 17/00	
G 06 F 3/00	
G 06 F 9/00	

Shew-fen Lin 2/16/2007 (Assistant Examiner) (Date)		**Total Claims Allowed:** 12
G. White 2/21/07 (Legal Instruments Examiner) (Date)	(Primary Examiner) (Date) 2/20/2007	O.G. Print Claim(s) 12 / O.G. Print Figure 1

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SUPERVISORY PATENT EXAMINER